PRODUCT SPECIFICATION	Rev.No.	1.0 1 of 3
Subject: MINI USB PLUG&RECEPTACLE		
I. SCOPE		
This specification covers performance, methods and quality requirements	s for Mini	
Universal Serial Bus(USB)type plug and receptacle connectors. These co	onnectors are	
cable mounted plug and printed circuit board mounted receptacle connec	ctors.	

2. REQUIREMENTS

2.1 Ratings

A.Voltage: 30V/AC(rms max)

B.Current: 1.0A per contact, not to exceed 30 °C temperature rise

C.Operating temperature: 0°C to+50°C

D.Storage temperature: -20 °C to+65 °C E.Nominal Temperature Rating: +20 °C

Item	Test Description	Test Requirement	Test Procedure
2.2.1	Critical dimension	8 total measurement within tolerance	EIA 364-18
2.2.2	Low level contact resistance	50mΩ Subject mated contacts assembled in hc housing to 20m maximum open circuit at 100mA maximum.	EIA 304-23
2.2.3	Insulation resistance	100MΩ minimum	EIA 364-21 Test voltage 100±10V/DC between adjacent contacts of mated and unmated connector assemblies.
2.2.4	Dielectric withstanding voltage	No flashover&sparkover&excess leakage&breakdown	EIA 364-20 Test voltage 100V/AC between adjacent contacts of mated and unmated connector assemblies.
2.2.5	Vibration, random	No discontinuities of 1 u s or Longer duration. See Note.	E1A364-28A-83 Condition III Test Letter A. Subject mated connectors to 5.35 G's rms. 15 minutes in each of three mutually perpendicular planes.
2.2,6	Physical shock	No discontinuities of 1 u s or Longer duration. See Note.	EIA 364-27 Condition H. Subject mated connectors to 30 Gs half-sine shock' pulses of 11 ms duration, Three shocks in each direction applied along three mutually perpendicular planes, 18 total shocks.
2.2.7	Durability	1500cycles insertion/extaction at a maximum rate of 200cycles per bour.	EIA 364-09

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Item	Test Description	Test Requirement	Test Procedure		
2.2.8	Solderability	Mini USB contact solder tails she pass 95% coverage after one hour steam aging as specified in category 2.			
2.2.9	Cable pull-out	Applied a load of 40 Newtons for one minute.		idition A	
2.2.10	Mating force	35Newtons maximum	EIA 364-13 Measure force necessary to mate connec Assemblies at maximumrate of 12.5 mi		
2.2.11	Unmating force	7 Newtons minimum initial; 3 Newtons minimum after 1500 cycles mating and unmating.	EIA 364-13 Measure force necessary to unmate connector assemblies at maximum rate of 12.5 mm/min.		
2,2,12	Thermal shock	10Cycles -55°C and+85°C, The USB connectors under test must be mated.	EIA 364-32 Test Condition I.		
2.2.13	Humidity life	168 Hours minimum (seven complete cycles).	The Mini USB 4P connectors under test be tested in accordance must EIA364 -31 Condition A. method III.		
2.2.14	Temperature life	See Note	EIA364-17A-87 Condition 2 Method A. Subject mated connectors to temperature Life 85℃ for 250 hours		
2.2.15	Mixed flowing gas	See Note	EIA364-65-92 Class (1)Unmated for 1 da		
2.2.16	Flammability	Require its thermoplastic resin vendor to supply a detailed C of C with each resin shipment. The C of C shall clearly show the resin's UL listing number, lot number, date code, etc.	UL94 v-0		
2.2.17	Contact capacitance	2 pF maximum unmated per contact.	EIA 364-30 The object of this test is to detail a standard method to determine the capacitance between conductive elements of a Mini USB connector.		
2.2.18	Contact current rating	temperature of 25°C, with power	EIA364-70method The object of this test to detail a standard n assess the current ca of mated Mini USB	d B st procedure is nethod to rrying capacity	

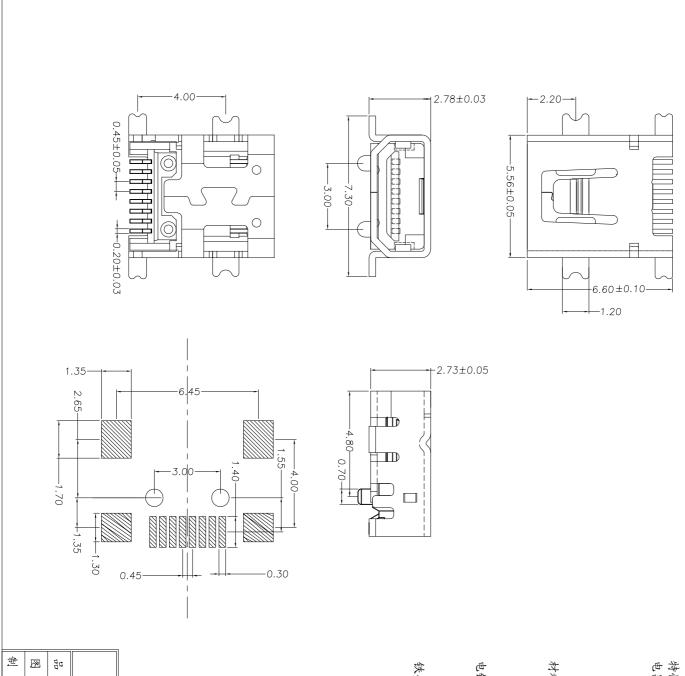
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Item	Test Description	Test Requirement		Test Procedure		
2.2.19	Differential impedance	90± 15%Ω		Connect the Time Domain Reflectomet (TDR).TDR is setup the differential mod		
		$(76.5 \sim 103.5\Omega)$				
2,2,20	Common mode impedance	30±30%Ω		Connect the Time Domain Reflectomes (TDR).TDR is setup the differential mod Connect the Time Domain Reflectomes (TDR).TDR is setup the differential mod Connect the Time Domain Reflectomes (TDR).TDR is setup the differential mod		
2.4.20		(21~39Ω)				
2.2.21	Propagation delay	18ns				
		(maximum for Low speed cable)				
2.2.22	Propagation delay skew	1 0 M 10 10 10 10 10 10 10 10 10 10 10 10 10				
	E-154 - 82					
	Signal pair attenuation	0.064MHz	0.08dB/Cable	1.Connect the network analyzer		
	(Maximum)	0.256MHz	0.11dB/Cable	output port(porl) to the input connector on the attenuation test fixture(note). 2.Connect the series"A"plug of		
		0.512MHz	0.13dB/Cable			
		0.772MHz	0.15dB/Cable			
		1.000MHz	0.20dB/Cable			
2.2.23		4.000MHz	0.39dB/Cable	the cable to be tested to the te	d to the test	
		8.000MHz	0.57dB/Cable	fixture, leaving the other end open-circuited.		
		12.00MHz	0.67dB/Cable			
		24.00MHz	0.95dB/Cable	3.Calibrate the netw	ork analyzer	
		48.00MHz	1.35dB/Cable	and fixture using th	ne appropriate	
		96.00MHz	1.90dB/Cable	calibration standard	ls over the	
		4.4		desired frequency	range.	

2.3 Product Qualification Test Sequence

Test or Measurement Item		Test Group(a)			
		1	П	Ш	
		Test Sequence(b)			
		1,10	1,5	1,9	
Low level contact resistance		3,7	2,4		
Capacitance				2	
Insulation res	istance			3,7	
DWV	- 6		8 6	4,8	
Vibration		5			
Physical shock		6			
Durability		4			
Mating force		2	9		
Unmating force		8			
Temperature life			3		
Thermal shock		î		5	
Humidity life		9		6	
Cable pull-ou	t	9			
Number of Plugs		9pcs	9pcs	9pcs	
Samples	Sockets	9pcs	9pcs	9pcs	

Samples Sockets 9pcs 9pcs 9pcs

Note: The high frequency performance shall be measure especially with network analyzer and TDR.For example impedance, attenuation, propagation delay and skew etc. parameters.



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	A016-1D	MINI USB 8P 四脚 SMT 母座 (MOLDING双边倒角)			
审	图纸编号	材			
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